

Notice of References Cited

Application No.
09/106,784

Applicant(s)
Pednault

Examiner
Samuel Broda

Group Art Unit
2763

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U.S. PATENT DOCUMENTS

		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
	A	5,970,482	10/1999	Pham et al	706	16
	B	5,842,189	11/1998	Keeler et al	706	16
	C	5,819,006	10/1998	Keeler et al	706	25
	D	5,675,553	10/1997	O'Brien, Jr. et al	367	135
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
	M					

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
	N						
	O						
	P						
	Q						
	R						
	S						
	T						

NON-PATENT DOCUMENTS

		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
	U	Cowell et al, "Sequential Model Criticism in Probabilistic Expert Systems", IEEE Transactions on Pattern Analysis and Machine Intelligence, Vol. 15 No. 3, pp. 209-219	3/1993
	V		
	W		
	X		